

Search Notes

Application/Control No.

10/666,723

Examiner

NAHEED EJAZ

Applicant(s)/Patent under
Reexamination

ZENG ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	130,131, 136,140, 147,150, 152	3/5/2008	NE
375	316,317	3/5/2008	NE
375	340,343	3/5/2008	NE
375	345	3/5/2008	NE
455	130,218	3/5/2008	NE
455	219,230	3/5/2008	NE
455	232.1	3/5/2008	NE

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search attached	3/5/2008	NE
Inventorship	3/5/2008	NE
Consulted with SPE Chieh M. Fan	3/5/2008	NE